

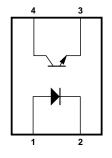
# Agilent HCPL-817 **Phototransistor Optocoupler High Density Mounting Type Data Sheet**

### Description

The HCPL-817 contains a light emitting diode optically coupled to a phototransistor. It is packaged in a 4-pin DIP package and available in wide-lead spacing option and lead bend SMD option. Input-output isolation voltage is 5000 Vrms. Response time,  $t_r$ , is typically 4  $\mu$ s and minimum CTR is 50% at input current of 5 mA.

### **Functional Diagram**

PIN NO. AND INTERNAL CONNECTION DIAGRAM



1. ANODE 3. EMITTER 2. CATHODE 4. COLLECTOR

### **Ordering Information**

Specify part number followed by Option Number (if desired).

HCPL-817-XXX **Option Number** 

060 = VDE0884 Option

W00 = 0.4" Lead Spacing Option

300 = Lead Bend SMD Option

500 = Tape and Reel Packaging

Option

00A = Rank Mark A

00B = Rank Mark B

00C = Rank Mark C

00D = Rank Mark D

00L = Rank Mark L

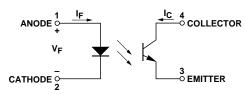
**Features** 

- Current Transfer Ratio (CTR: min. 50% at  $I_F = 5$  mA.  $V_{CE} = 5 V$
- High input-output isolation voltage  $(V_{iso} = 5000 Vrms)$
- Response time (t<sub>r</sub>: typ., 4 µs at  $V_{CE} = 2 V$ ,  $I_C = 2 mA$ ,  $R_L = 100 \Omega$ )
- Compact dual-in-line package
- **UL** approved
- **CSA** approved
- **VDE** approved
- **Options available:** 
  - Leads with 0.4" (10.16 mm) spacing (W00)
  - Leads bends for surface mounting (300)
  - Tape and reel for SMD (500)
  - VDE 0884 approvals (060)

### **Applications**

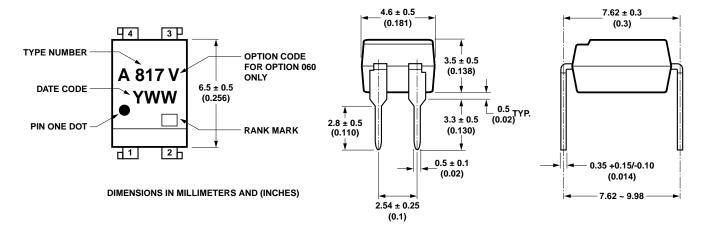
- Signal transmission between circuits of different potentials and impedances
- I/O interfaces for computers
- Feedback circuit in power supply

**Schematic** 

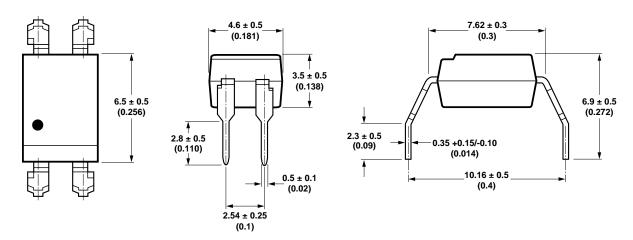


**CAUTION:** It is advised that normal static precautions be taken in handling and assembly of this component to prevent damage and/or degradation which may be induced by ESD.

### **Package Outline Drawings**

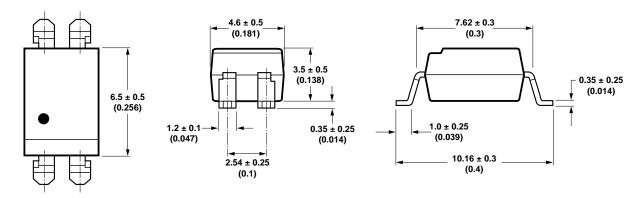


### Package Outline - Option W00



**DIMENSIONS IN MILLIMETERS AND (INCHES)** 

### Package Outline - Option 300



DIMENSIONS IN MILLIMETERS AND (INCHES)

# Absolute Maximum Ratings ( $T_A = 25^{\circ}C$ )

Storage Temperature, T <sub>S</sub>	–55°C to +125°C
Operating Temperature, T <sub>A</sub>	−30°C to +100°C
Lead Solder Temperature, max.	260°C for 10 s
(1.6 mm below seating plane)	
Average Forward Current, I <sub>F</sub>	50 mA
Reverse Input Voltage, V <sub>R</sub>	6 V
Input Power Dissipation, P <sub>I</sub>	70 mW
Collector Current, I <sub>C</sub>	50 mA
Collector-Emitter Voltage, V <sub>CEO</sub>	35 V
Emitter-Collector Voltage, V <sub>ECO</sub>	6 V
Collector Power Dissipation	150 mW
Total Power Dissipation	200 mW
Isolation Voltage, V <sub>iso</sub> (AC for 1 minute, R.H. = 40 ~ 60%)	5000 Vrms

# Electrical Specifications ( $T_A = 25^{\circ}C$ )

Parameter	Symbol	Min.	Тур.	Max.	Units	Test Conditions
Forward Voltage	V <sub>F</sub>	_	1.2	1.4	V	I <sub>F</sub> = 20 mA
Reverse Current	I <sub>R</sub>	_	_	10	μΑ	V <sub>R</sub> = 4 V
Terminal Capacitance	Ct	_	30	250	pF	V = 0, f = 1 KHz
Collector Dark Current	I <sub>CEO</sub>	_	_	100	nA	V <sub>CE</sub> = 20 V
Collector-Emitter Breakdown Voltage	BV <sub>CEO</sub>	35	_	_	V	I <sub>C</sub> = 0.1 mA
Emitter-Collector Breakdown Voltage	BV <sub>ECO</sub>	6	_	_	V	Ι <sub>Ε</sub> = 10 μΑ
Collector Current	Ic	2.5	_	30	mA	$I_F = 5 \text{ mA}, V_{CE} = 5 \text{ V},$
*Current Transfer Ratio	CTR	50	_	600	%	$R_{BE} = \infty$
Collector-Emitter Saturation Voltage	V <sub>CE(sat)</sub>	_	0.1	0.2	V	I <sub>F</sub> = 20 mA, I <sub>C</sub> = 1 mA
Response Time (Rise)	t <sub>r</sub>	_	4	18	μs	$V_{CC} = 2 \text{ V, } I_{C} = 2 \text{ mA}$
Response Time (Fall)	t <sub>f</sub>	_	3	18	μs	$R_L = 100 \Omega$
Cut-off Frequency	f <sub>c</sub>	-	80	_	KHz	$V_{CC}$ = 5 V, $I_C$ = 2 mA $R_L$ = 100 $\Omega$ , $-3~\mathrm{dB}$
Isolation Resistance	R <sub>iso</sub>	5 x 10 <sup>10</sup>	1 x 10 <sup>11</sup>	-	Ω	DC 500 V 40 ~ 60% R.H.
Floating Capacitance	Cf	_	0.6	1.0	pF	V = 0, f = 1 MHz

\* CTR = 
$$\frac{I_C}{I_F}$$
 x 100%

Rank Mark	CTR (%)	Conditions
L	50 ~ 100	$I_F = 5 \text{ mA}, V_{CE} = 5 \text{ V}, T_A = 25^{\circ}\text{C}$
Α	80 ~ 160	
В	130 ~ 260	<del></del>
С	200 ~ 400	
D	300 ~ 600	<u> </u>

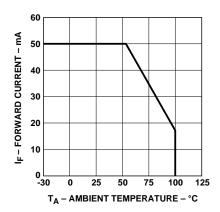


Figure 1. Forward current vs. temperature.

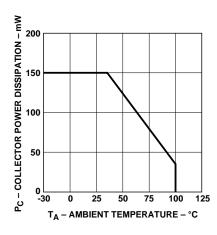


Figure 2. Collector power dissipation vs. temperature.

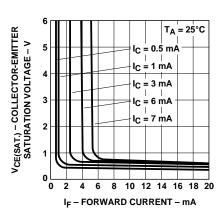


Figure 3. Collector-emitter saturation voltage vs. forward current.

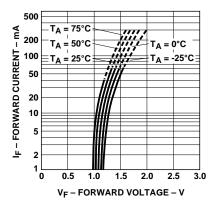


Figure 4. Forward current vs. forward voltage.

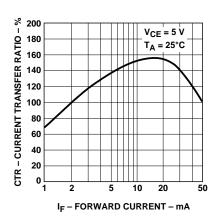


Figure 5. Current transfer ratio vs. forward current.

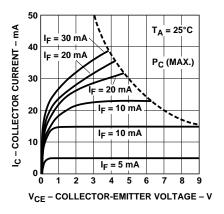


Figure 6. Collector current vs. collectoremitter voltage.

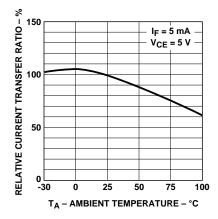


Figure 7. Relative current transfer ratio vs. temperature.

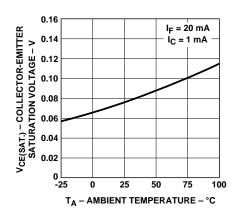


Figure 8. Collector-emitter saturation voltage vs. temperature.

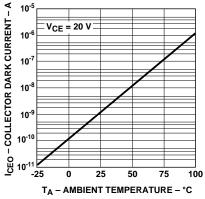
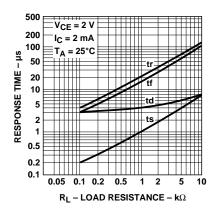


Figure 9. Collector dark current vs. temperature.



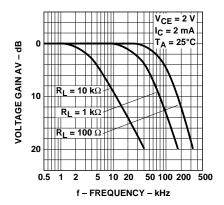
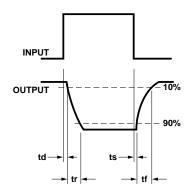


Figure 10. Response time vs. load resistance.

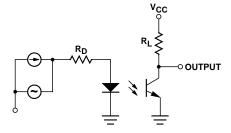
Figure 11. Frequency response.

## **Test Circuit for Response Time**

# INPUT O RD RL OUTPUT



## **Test Circuit for Frequency Response**





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